Application/Control No.	Applicant(s)/Patent under Reexamination
09/849,695	BLACK ET AL.
Examiner	Art Unit

Susan F. Rayyan

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	QEAD	CHED		
SEARCHED				
Class	Subclass	Date	Examiner	
707	2-4,7,9- 10,102, 104.1	1/9/2006	SR	
705	2,4,7,18,	1/9/2006	SR	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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S (INCLUDIN	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR	
EAST	1/9/2006	SR	
IEEE	1/9/2006	SR	
EIC	1/9/2006	SR	